

TEST REPORT

Applicant: Quectel Wireless Solutions Co., Ltd.

EUT Description: LTE Cat 1 bis Module

Model: EG915N-LA

Brand: QUECTEL

FCC ID: XMR202508EG915NLA

Standards: CFR 47, FCC Part 2
CFR 47, FCC Part 22
CFR 47, FCC Part 24
CFR 47, FCC Part 27

Date of Receipt: 2026/08/06

Date of Test: 2026/08/06 to 2026/08/25

Date of Issue: 2026/08/25

TOWE tested the above equipment in accordance with the requirements set forth in the above standards. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. It is the manufacturer's responsibility to assure that additional production units of the model are manufactured with identical electrical and mechanical components. All samples tested were in good operating condition throughout the entire test program. Measurement Uncertainties are published for informational purposes only and were not taken into account unless noted otherwise. Without written approval of TOWE, the test report shall not be reproduced except in full.

CFR 47, FCC Part 2 is a general rules and regulations document rather than a testing standard, and as such falls outside the scope of A2LA accreditation. All other FCC standards referenced in this report are within the laboratory's accredited scope.




Jim Huang
Approved By:



Carey Chen
Reviewed By:

Revision History

Rev.	Issue Date	Description	Revised by
01	2026/08/25	Original	Carey Chen

Summary of Test Results

FCC Part	Test Band	Test Item	Test Result
§2.1046 §22.913(a)(5)	LTE Band 5	Effective Radiated Power	Pass
§2.1046 §24.232(c) §27.50(d)(4) §27.50(h)(2)	LTE Band 2 LTE Band 4/66 LTE Band 7	Effective Isotropic Radiated Power	Pass
§22.913(d) §24.232(d) §27.50(d)(5)	LTE Band 5 LTE Band 2 Others Band	Peak-Average Ratio	Pass
§2.1049	All Band	Occupied Bandwidth	Pass
§2.1051 §22.917(a) §24.238(a) §27.53(h) §27.53(m)	LTE Band 5 LTE Band 2 LTE Band 4/66 LTE Band 7	Band Edge	Pass
§2.1051 §22.917(a) §24.238(a) §27.53(h) §27.53(m)	LTE Band 5 LTE Band 2 LTE Band 4/66 LTE Band 7	Spurious Emission at Antenna Terminals	Pass
§2.1053 §22.917(a) §24.238(a) §27.53(h) §27.53(m)	LTE Band 5 LTE Band 2 LTE Band 4/66 LTE Band 7	Field Strength of Spurious Radiation	Pass
§2.1055 §22.355 §24.235 §27.54	LTE Band 5 LTE Band 2 Others Band	Frequency Stability	Pass
Remark: Pass: Meet the requirement.			

Table of Contents

1	General Description	5
1.1	Lab Information.....	5
1.1.1	Testing Location	5
1.1.2	Test Facility / Accreditations	5
1.2	Client Information	5
1.2.1	Applicant.....	5
1.2.2	Manufacturer.....	5
1.3	Product Information.....	6
2	Test Configuration	7
2.1	Test Channel	7
2.2	Test Mode	9
2.3	Support Unit used in test	9
2.4	Test Environment.....	9
2.5	Test RF Cable	9
2.6	Modifications.....	9
2.7	Test Setup Diagram	10
2.7.1	Conducted Configuration	10
2.7.2	Radiated Configuration	11
3	Equipment and Measurement Uncertainty.....	12
3.1	Test Equipment List.....	12
3.2	Measurement Uncertainty	13
4	Test Results.....	14
4.1	Output Power (ERP / EIRP / Conducted Power)	14
4.2	Peak-Average Ratio	15
4.3	Occupied Bandwidth	16
4.4	Band Edge and Emission Mask	17
4.5	Spurious Emission at Antenna Terminals	18
4.6	Field Strength of Spurious Radiation.....	19
4.7	Frequency Stability V.S. Temperature, Voltage.....	21
5	Test Setup Photos.....	22
	Appendix.....	23

1 General Description

1.1 Lab Information

1.1.1 Testing Location

These measurement tests were conducted at the Sushi TOWE Wireless Testing (Shenzhen) Co., Ltd. facility located at F 401 and F 101, Building E, Hongwei Industrial Zone, No. 6, Liuxian 3rd Road, Zone 70, Xingdong Community, Xin'an Street, Bao'an District, Shenzhen, People's Republic of China. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014

Tel.: +86-755-27212361

Contact Email: info@towewireless.com

1.1.2 Test Facility / Accreditations

A2LA (Certificate Number: 7088.01)

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

FCC Designation No.: CN1353

Sushi TOWE Wireless Testing (Shenzhen) Co., Ltd. has been recognized as an accredited testing laboratory.

Test Firm Registration Number: 684095

Designation Number: CN1353.

ISED CAB identifier: CN0152

Sushi TOWE Wireless Testing (Shenzhen) Co., Ltd. has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0152

Company Number: 31000

1.2 Client Information

1.2.1 Applicant

Applicant:	Quectel Wireless Solutions Co., Ltd.
Address:	8 Waipojing Road, Sijing Town, Songjiang District, Shanghai 201601, China

1.2.2 Manufacturer

Manufacturer:	Quectel Wireless Solutions Co., Ltd.
Address:	8 Waipojing Road, Sijing Town, Songjiang District, Shanghai 201601, China

1.3 Product Information

EUT Description:	LTE Cat 1 bis Module		
Model:	EG915N-LA		
Brand:	QUECTEL		
Hardware Version:	EG915N-LA(AN): R3.0 EG915N-LA(AK): R3.1		
Software Version:	EG915N-LA(AN): EG915NLAANR10A01M08 EG915N-LA(AK): EG915NLAAGR10A04M08		
Power Class:	Class 3: All		
SN.:	RF Conducted	P1M25K20F001250	
	RSE	D1Y26DJ51000015	
Device Capabilities:			
LTE Type:	☒ LTE Cat 1bis		
Modulation Type:	LTE:	☒ QPSK, ☒ 16QAM	
Operation Frequency Range:	Band	TX Frequency	RX Frequency
	LTE Band 2	1850 ~ 1910 MHz	1930 ~ 1990 MHz
	LTE Band 4	1710 ~ 1755 MHz	2110 ~ 2155 MHz
	LTE Band 5	824 ~ 849 MHz	869 ~ 894 MHz
	LTE Band 7	2500 ~ 2570 MHz	2620 ~ 2690 MHz
	LTE Band 66	1710 ~ 1780 MHz	2110 ~ 2180 MHz
Antenna Type:	☒ External, ☐ Integrated		
Antenna Gain:	Band	Ant (dBi)	
	LTE Band 2	1.59	
	LTE Band 4	2.00	
	LTE Band 5	2.53	
	LTE Band 7	3.00	
	LTE Band 66	2.00	
Remark: The above EUT's information was declared by applicant, please refer to the specifications or user manual for more detailed description.			

2 Test Configuration

2.1 Test Channel

Band	Bandwidth	TX Frequency			RX Frequency		
		Range	Channel	Frequency	Range	Channel	Frequency
LTE Band 2	1.4MHz	Low	18607	1850.7 MHz	Low	607	1930.7 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19193	1909.3 MHz	High	1193	1989.3 MHz
	3MHz	Low	18615	1851.5 MHz	Low	615	1931.5 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19185	1908.5 MHz	High	1185	1988.5 MHz
	5MHz	Low	18625	1852.5 MHz	Low	625	1932.5 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19175	1907.5 MHz	High	1175	1987.5 MHz
	10MHz	Low	18650	1855 MHz	Low	650	1935 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19150	1905 MHz	High	1150	1985 MHz
	15MHz	Low	18675	1857.5 MHz	Low	675	1937.5 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19125	1902.5 MHz	High	1125	1982.5 MHz
LTE Band 4	1.4MHz	Low	18700	1860 MHz	Low	700	1940 MHz
		Middle	18900	1880 MHz	Middle	900	1960 MHz
		High	19100	1900 MHz	High	1100	1980 MHz
	3MHz	Low	19957	1710.7 MHz	Low	1957	2110.7 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20393	1754.3 MHz	High	2393	2154.3 MHz
	5MHz	Low	19965	1711.5 MHz	Low	1965	2111.5 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20385	1753.5 MHz	High	2385	2153.5 MHz
	10MHz	Low	19975	1712.5 MHz	Low	1975	2112.5 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20375	1752.5 MHz	High	2375	2152.5 MHz
	15MHz	Low	20000	1715 MHz	Low	2115	2115 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20350	1750 MHz	High	2350	2150 MHz
	20MHz	Low	20025	1717.5 MHz	Low	2025	2117.5 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20325	1747.5 MHz	High	2325	2147.5 MHz
LTE Band 5	1.4MHz	Low	20050	1720 MHz	Low	2050	2120 MHz
		Middle	20175	1732.5 MHz	Middle	2175	2132.5MHz
		High	20300	1745 MHz	High	2300	2145 MHz
	3MHz	Low	20407	824.7 MHz	Low	2407	869.7 MHz
		Middle	20525	836.5 MHz	Middle	2525	881.5 MHz
		High	20643	848.3 MHz	High	2643	893.3 MHz
	5MHz	Low	20415	825.5 MHz	Low	2415	870.5 MHz
		Middle	20525	836.5 MHz	Middle	2525	881.5 MHz
		High	20635	847.5 MHz	High	2635	892.5 MHz
	10MHz	Low	20425	826.5 MHz	Low	2425	871.5 MHz
		Middle	20525	836.5 MHz	Middle	2525	881.5 MHz
		High	20625	846.5 MHz	High	2625	891.5 MHz
LTE Band 7	5MHz	Low	20450	829 MHz	Low	2450	874 MHz
		Middle	20525	836.5 MHz	Middle	2525	881.5 MHz
		High	20600	844 MHz	High	2600	889 MHz
	10MHz	Low	20775	2502.5 MHz	Low	2775	2622.5 MHz
		Middle	21100	2535 MHz	Middle	3100	2655 MHz

Band	Bandwidth	TX Frequency			RX Frequency		
		Range	Channel	Frequency	Range	Channel	Frequency
	15MHz	High	21400	2565 MHz	High	3400	2685 MHz
		Low	20825	2507.5 MHz	Low	2825	2627.5 MHz
		Middle	21100	2535 MHz	Middle	3100	2655 MHz
	20MHz	High	21375	2562.5 MHz	High	3375	2682.5 MHz
		Low	20850	2510 MHz	Low	2850	2630 MHz
		Middle	21100	2535 MHz	Middle	3100	2655 MHz
		High	21350	2560 MHz	High	3350	2680 MHz
LTE Band 66	1.4MHz	Low	131979	1710.7 MHz	Low	66443	2110.7 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132665	1779.3 MHz	High	67129	2179.3 MHz
	3MHz	Low	131987	1711.5 MHz	Low	66451	2111.5 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132657	1778.5MHz	High	67121	2178.5MHz
	5MHz	Low	131997	1712.5 MHz	Low	66461	2112.5 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132647	1777.5 MHz	High	67111	2177.5 MHz
	10MHz	Low	132022	1715 MHz	Low	66486	2115 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132622	1775 MHz	High	67086	2175 MHz
	15MHz	Low	132047	1717.5 MHz	Low	66511	2117.5 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132597	1772.5 MHz	High	67061	2172.5 MHz
	20MHz	Low	132072	1720 MHz	Low	66536	2120 MHz
		Middle	132322	1745 MHz	Middle	66786	2145MHz
		High	132572	1770 MHz	High	67036	2170 MHz

2.2 Test Mode

Test Mode	Description
TM 1	EUT communication with simulated station in LTE/QPSK mode
TM 2	EUT communication with simulated station in LTE/16QAM mode

2.3 Support Unit used in test

Description	Manufacturer	Model	Serial Number
Development Board*	QUECTEL	UMTS<E-EVB	MP822CJ12000539
Development Board*	QUECTEL	EG915N-LA-TE-A	E1M26B50U000011

Remark: *the information are provided by applicant.

2.4 Test Environment

Temperature:	Normal: 15°C ~ 35°C, Extreme: -30°C ~ +50°C
Relative Humidity:	45 ~ 56 % RH Ambient
Voltage:	Nominal: 3.80 Vdc, Extreme: Low 3.40 Vdc, High 4.50 Vdc

2.5 Test RF Cable

For all conducted test items: The offset level is set spectrum analyzer to compensate the RF cable loss and attenuator factor between RF conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level will be exactly the RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

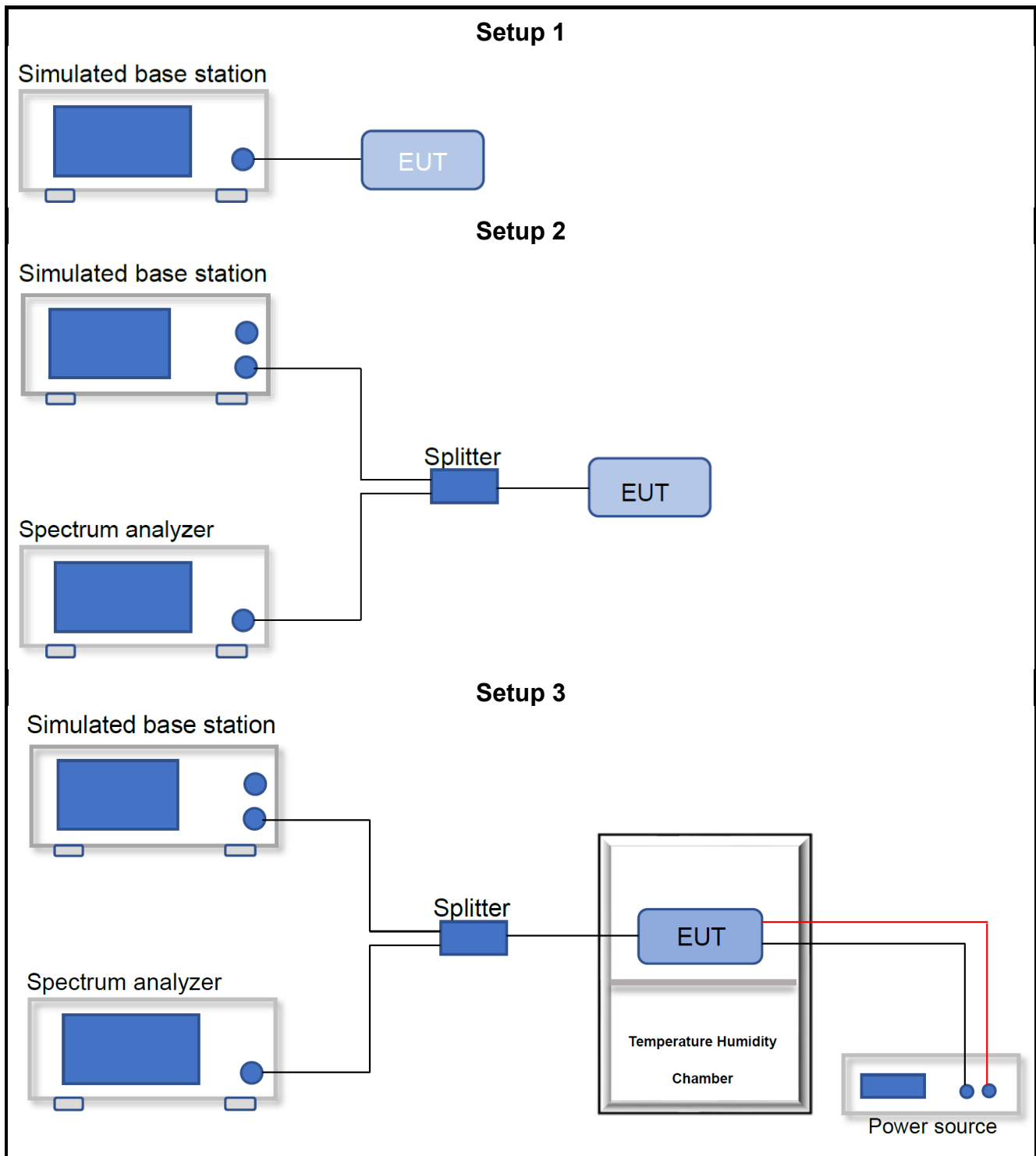
Offset = RF cable loss + attenuator factor.

2.6 Modifications

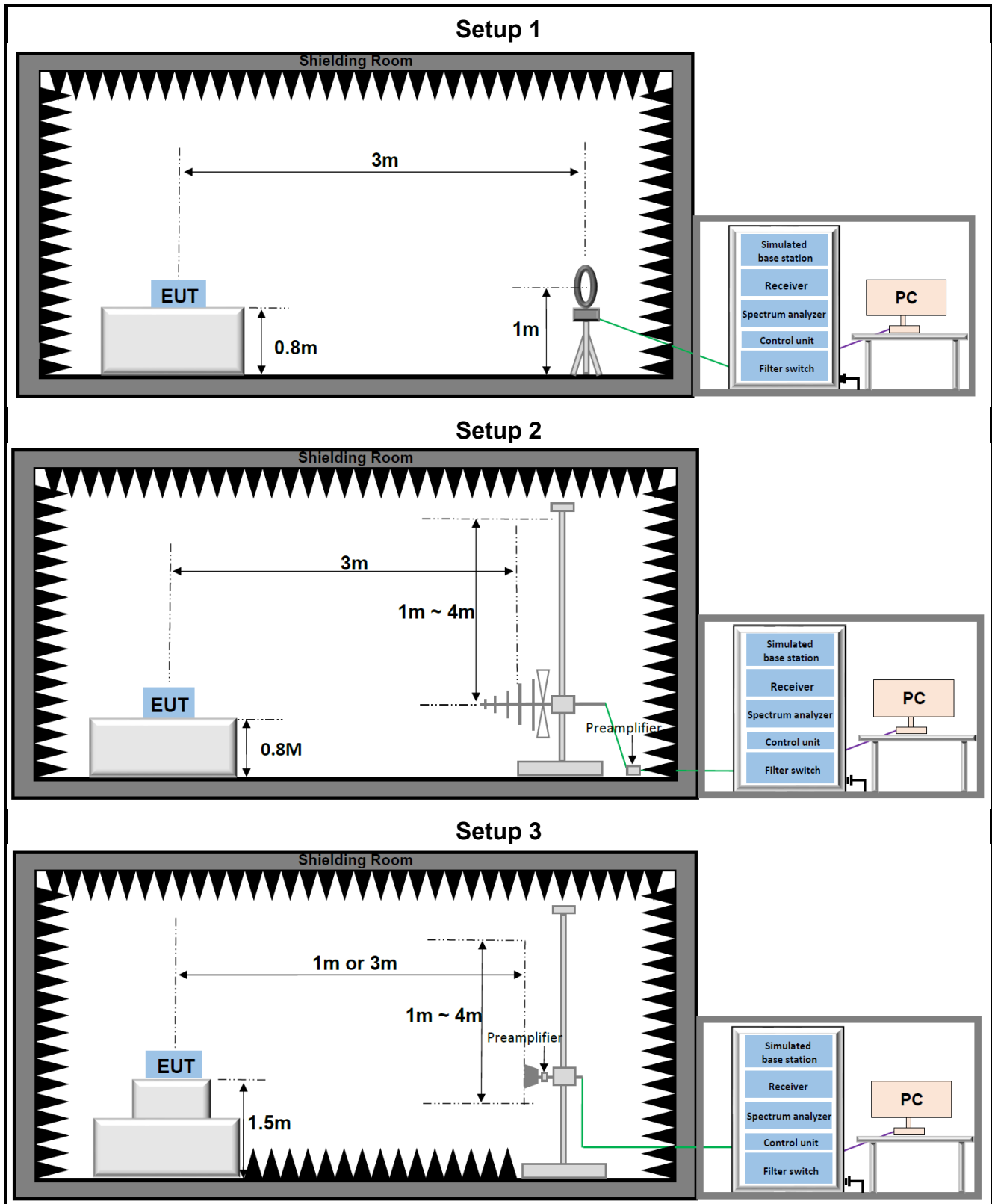
No modifications were made during testing.

2.7 Test Setup Diagram

2.7.1 Conducted Configuration



2.7.2 Radiated Configuration



3 Equipment and Measurement Uncertainty

All test and measuring equipment utilized to perform the tests documented in this report are calibrated on a regular basis, whichever is less, and where applicable is traceable recognized national standards.

3.1 Test Equipment List

RF Conducted 04					
Description	Manufacturer	Model	S.N.	Last Due	Cal Due
Radio Communication Analyzer	Anritsu	MT8821C	6262170436	2026/03/05	2027/03/04
Signal Analyzer	Keysight	N9020A	US46220152	2026/03/05	2027/03/04
Signal Generator	Keysight	N5182A	MY49060761	2026/03/05	2027/03/04
Signal Generator	R&S	SMR20	101691	2026/03/05	2027/03/04
Hygrometer	BingYu	HTC-1	N/A	2025/05/29	2027/05/28
EXA Signal Analyzer, Multi-touch	Keysight	N9010B	MY63440541	2026/05/29	2027/05/28
Band Reject Filter Group	Tonscend	JS0806-F	23B806F0662	N/A	N/A
RF Control Unit	Tonscend	JS0806-1	22L8060650	N/A	N/A
Measurement Software	Tonscend	TS1120 V3.1.46	10636	N/A	N/A

Radiated Emission					
Description	Manufacturer	Model	S.N.	Last Due	Cal Due
Double-Ridged Horn Antennas	Tonscend	HA32-18	806HA003608251015	2025/12/13	2028/12/12
Biconic Logarithmic Periodic Antennas	Tonscend	BLA32-30	80SBLA001011251010	2025/12/13	2028/12/12
Broad-Band Horn Antenna	Schwarzbeck	BBHA 9170	1290	2026/06/18	2029/06/17
Loop Antenna	Schwarzbeck	FMZB 1519C	1519C-028	2026/06/13	2029/06/12
Signal Analyzer	Keysight	N9020A	MY57120015	2026/01/19	2028/01/18
EXA Signal Analyzer, Multi-touch	Keysight	N9010B	MY63440541	2026/05/29	2027/05/28
Wideband Radio Communication Tester	R&S	CMW500	150645	2026/03/06	2027/03/05
Low Noise Amplifier	Tonscend	TAP9K3G40	806JSAP044710251054	2026/01/19	2028/01/18
Low Noise Amplifier	Tonscend	TAP01018050	806JSAF044509251052	2026/01/19	2028/01/18
Low Noise Amplifier	Tonscend	TAP18040048	AP22G806247	2025/03/11	2027/03/10
Hygrometer	BINGYU	HTC-1	N/A	2026/07/24	2027/07/23
Test Software	Tonscend	TS+	Version: 5.0.0	N/A	N/A

3.2 Measurement Uncertainty

Parameter	U _{lab}
Frequency error	50.30Hz
Output Power	0.76dB
Conducted spurious emissions	2.22dB
Radiated Emissions(9kHz~30MHz)	2.42dB
Radiated Emissions(30MHz~1000MHz)	4.62dB
Radiated Emissions(1GHz~18GHz)	5.30dB
Radiated Emissions(18GHz~40GHz)	5.52dB

Uncertainty figures are valid to a confidence level of 95%

4 Test Results

4.1 Output Power (ERP / EIRP / Conducted Power)

Limits

FCC Part	Test Band	Limit
§22.913(a)(5)	LTE Band 5	The ERP of mobile transmitters and auxiliary test transmitters must not exceed 7watts.
§24.232(c)	LTE Band 2	Mobile and portable stations are limited to 2 watts EIRP and the equipment must employ a means for limiting power to the minimum necessary for successful communications.
§27.50(h)(2)	LTE Band 7	Mobile and other user stations. Mobile stations are limited to 2.0 watts EIRP. All user stations are limited to 2.0 watts transmitter output power
§27.50(d)(4)	LTE Band 4/66	Fixed, mobile, and portable (hand-held) stations operating in the 1710-1755MHz band and mobile and portable stations operating in the 1695-1710 MHz and 1755-1780MHz bands are limited to 1watt EIRP. Fixed stations operating in the 1710-1755MHz band are limited to a maximum antenna height of 10 meters above ground. Mobile and portable stations operating in these bands must employ a means for limiting power to the minimum necessary for successful communications.

Test Procedure

KDB 971168 D01 V03r01 Section 5.2.1, for Conducted Output Power

KDB 971168 D01 V03r01 Section 5.2, for Effective (Isotropic) Radiated Power

Test Settings

Conducted Output Power:

The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated base station. The simulated station was set to force the EUT to its maximum power setting, Transmitter output power was read off in dBm, read values have added cable loss and attenuation.

Radiated Power:

The formula for calculating ERP/EIRP based on conduction power is as follows:

$EIRP\ (dBm) = \text{Conducted Power}\ (dBm) + \text{antenna gain}\ (dBi)$

$ERP = EIRP - 2.15dB$

Test Setup

Refer to section 2.7.1 Setup 1

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Results

The detailed test data see: **Appendix**.

4.2 Peak-Average Ratio

Limits

§22.913(d): The peak-to-average ratio (PAR) of the transmission must not exceed 13 dB.

§24.232(d): The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.

§27.50(d)(5): The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.

Test Procedure

KDB 971168 D01 V03r01 Section 5.7.1

Test Settings

The following guidelines are offered for performing a CCDF measurement.

1. Set resolution/measurement bandwidth $\geq$ OBW or specified reference bandwidth.
2. Set the number of counts to a value that stabilizes the measured CCDF curve.
3. Set the measurement interval as follows:
 - a) For continuous transmissions, set to the greater of $[10 \times (\text{number of points in sweep}) \times (\text{transmission symbol period})]$ or 1 ms.
 - b) For burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize. Set the measurement interval to a time that is less than or equal to the burst duration.
 - c) If there are several carriers in a single antenna port, the peak power shall be determined for each individual carrier (by disabling the other carriers while measuring the required carrier) and the total peak power calculated from the sum of the individual carrier peak powers.
4. Record the maximum PAPR level associated with a probability of 0.1%.
5. The peak power level is calculated from the sum of the PAPR value from step d) to the measured average power.

Test Setup

Refer to section 2.7.1 Setup 2

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

4.3 Occupied Bandwidth

Limits

For Reporting Purposes only

Test Procedure

KDB 971168 D01 V03r01 Section 4.2 & 4.3

Test Settings

1. The transmitter output was connected to a calibrated coaxial cable and coupler, The other end is connected to the spectrum analyzer and simulated station.
2. The signal analyzer automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by ant intermediate power nulls in the fundamental emission.
3. The simulated base station was set to force the EUT to its maximum transmitting power.
4. RBW = 1 - 5% of the expected OBW
5. VBW $\geq$ 3 times the RBW
6. Sweep = Auto
7. Detector = Peak
8. Trace = Max hold
9. The trace was allowed to stabilize

Test Setup

Refer to section 2.7.1 Setup 2

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

4.4 Band Edge and Emission Mask

Limits

FCC part	Test Band	Limit
§22.917(a) §24.238(a) §27.53(h)	LTE Band 5 LTE Band 2 LTE Band 4/66	The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.
§27.53(m)	LTE Band 7	For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log(P)$ dB on all frequencies between the channel edge and 5 MHz from the channel edge, $43 + 10 \log(P)$ dB on all frequencies between 5 MHz and X MHz from the channel edge, and $55 + 10 \log(P)$ dB on all frequencies more than X MHz from the channel edge, where X is the greater of 6 MHz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less than $43 + 10 \log(P)$ dB on all frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log(P)$ dB at or below 2490.5 MHz.

Test Procedure

KDB 971168 D01 V03r01 Section 6.0

Test Settings

1. The transmitter output was connected to a calibrated coaxial cable and coupler, The other end is connected to the spectrum analyzer and simulated station.
2. The simulated base station was set to force the EUT to its maximum transmitting power.
3. Start and stop frequency were set such that the band edge would be placed in the center of the plot.
4. RBW $\geq$ 1% of the emission bandwidth
5. VBW $\geq$ 3 times the RBW
6. Detector = RMS
7. Number of sweep point $\geq$ 2 times Span/RBW
8. Sweep = Auto
9. Trace = Max hold
10. The trace was allowed to stabilize

Test Setup

Refer to section 2.7.1. Setup 2

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

4.5 Spurious Emission at Antenna Terminals

Limits

FCC part	Test Band	Limit
§22.917(a) §24.238(a) §27.53(h)	LTE Band 5 LTE Band 2 LTE Band 4/66	The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.
§27.53(m)	LTE Band 7	All frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log(P)$ dB at or below 2490.5 MHz.

Test Procedure

KDB 971168 D01 V03r01 Section 6.0

Test Settings

1. The transmitter output was connected to a calibrated coaxial cable and coupler, The other end is connected to the spectrum analyzer and simulated station.
2. The simulated base station was set to force the EUT to its maximum transmitting power.
3. Start frequency was set to 9kHz and stop frequency was set to 10th harmonic.
4. RBW and VBW (see test notes)
5. Detector = RMS
6. Sweep = Auto
7. Sweep point = below 30MHz(1001pts); 30MHz – 1GHz(2001pts); above 1GHz(40001pts)
8. Trace = trace average for continuous emissions, max hold for pulse emissions
9. Allow trace to fully stabilize

Test Notes

1. Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth 100kHz or greater for measurements below 1GHz. However, in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission is attenuated at least 26dB below the transmitter power
2. 9kHz – 150kHz: RBW=1kHz, VBW≥3 times the RBW
3. 150kHz – 30MHz: RBW=10kHz, VBW≥3 times the RBW

Test Setup

Refer to section 2.7.1. Setup 2

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

4.6 Field Strength of Spurious Radiation

Limits

FCC part	Test Band	Limit
§2.1053 §22.917(a) §24.238(a) §27.53(h)	LTE Band 5 LTE Band 2 LTE Band 4/66	The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.
§27.53(m)	LTE Band 7	All frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log(P)$ dB at or below 2490.5 MHz.

Test Procedure

KDB 971168 D01 V03r01 Section 7

Test Settings

- For radiated emissions measurements performed at frequencies less than or equal to 1GHz, the EUT shall be placed on a RF-transparent table or support at a nominal height of 80cm above the reference ground plane.
- For radiated emissions measurements performed at frequencies above 1GHz, the EUT shall be placed on a RF-transparent table or support at a nominal height of 150cm above the ground plane.
- Radiated measurements shall be made with the measurement antenna positioned in both horizontal and vertical polarization. The measurement antenna shall be varied from 1m to 4m in height above the reference ground in a search for the relative positioning that produces the maximum radiated signal level (i.e, field strength or received power), when orienting the measurement antenna in vertical polarization, the minimum height of the lowest element of the antenna shall clear the site reference ground plane by at least 25cm.
- For each suspected emission, the EUT was ranged its worst case and then tune the antenna tower(from 1~4m) and turntable(from 0~360°) find the maximum reading. Preamplifier and a high pass filter are used for the test in order get better signal level comply with the guidelines.
- The simulated base station was set to force the EUT to its maximum transmitting power.
- spectrum analyzer setting:
Measurements 9kHz ~150kHz: RBW = 300Hz; VBW ≥ 3kHz; Detector = RMS
Measurements 150kHz ~30MHz: RBW = 10kHz; VBW ≥ 30kHz; Detector = RMS
Measurements 30MHz~1000MHz: RBW = 100kHz or 1MHz; VBW ≥ 1MHz or 3MHz; Detector = RMS
Measurements Above 1000MHz: RBW = 1 MHz; VBW ≥ 3 MHz; Detector = RMS
- The field strength is calculated by adding the Antenna Factor, Cable Factor. The basic equation with a sample calculation is as follows:

$$E(\text{dB}\mu\text{V/m}) = \text{Measured amplitude level (dB}\mu\text{V)} + \text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)}.$$

$$E(\text{dB}\mu\text{V/m}) = \text{Measured amplitude level (dBm)} + 107 + \text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)}.$$

$$E(\text{dB}\mu\text{V/m}) = \text{EIRP(dBm)} - 20\log(D) + 104.8; \text{ where } D \text{ is the measurement distance(in the far field region) in m.}$$

$$\text{EIRP(dBm)} = E(\text{dB}\mu\text{V/m}) + 20\log(D) - 104.8; \text{ where } D \text{ is the measurement distance(in the far field region) in m.}$$

So, from d: The measuring distance is usually at 3m, then $20 \cdot \log(3) = 9.5424$
Then, $\text{EIRP (dBm)} = E(\text{dB}\mu\text{V/m}) + 9.5424 - 104.8 = E(\text{dB}\mu\text{V/m}) - 95.2576$
- Repeat above procedures until all frequencies measured was complete.
- Measure and record the results in the test report.

Test notes

- The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst-case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- Emissions below 18GHz were measured at a 3-meter test distance while emissions above 18GHz were measured at a 1-meter test distance with the application of a distance correction factor.
- Radiated spurious emissions were investigated from 9kHz to 30MHz, 30MHz-1GHz and above 1GHz. the disturbance between 9kHz to 30MHz, 30MHz-1GHz and 18GHz to 40GHz was very low. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be recorded, so only the harmonics had been displayed.

4. The "-" shown in the following RSE tables are used to denote a noise floor measurement.

Test Setup

Refer to section 2.7.2 for details.

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

4.7 Frequency Stability V.S. Temperature, Voltage

Limits

§22.355:

The carrier frequency shall not depart from the reference frequency in excess of ± 2.5 ppm for mobile stations.

§24.235 / §27.54:

The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Test Procedure

KDB 971168 D01 V03r01 Section 9

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Notes

- a.) Temperature:
The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) Primary Supply Voltage:
The primary supply voltage is varied from 85% to 115% of the nominal value for non-hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Test Setup

Refer to section 2.7.1 Setup 3

Measuring Instruments

The measuring equipment is listed in the section 3.1 of this test report.

Test Result

The detailed test data see: **Appendix**.

5 Test Setup Photos

For detailed test setup photos, see **Appendix-C WWAN Setup Photos**

Appendix

Appendix List:

Appendix-A LTE Band 2
Appendix-A LTE Band 4
Appendix-A LTE Band 5
Appendix-A LTE Band 7
Appendix-A LTE Band 66
Appendix-B Field Strength of Spurious Radiation-LTE

~The End~